

**Search Notes**

Application/Control No.

10/532,619

Examiner

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Applicant(s)/Patent under  
Reexamination

CHEN, ERNEST C.

Art Unit

2611

**SEARCHED**

Class	Subclass	Date	Examiner
375	295	11/28/2007	EB
375	262	11/28/2007	EB
375	324	11/28/2007	EB
375	265	11/28/2007	EB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
375	295	11/28/2007	EB
375	324	11/28/2007	EB

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	11/28/2007	EB